Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO.		SERIAL NO.		
				240064US0		10/617,397		
				APPLICANT				
LIST OF	REFE	RENCES CITED BY AF	PPLICANT	Masahide MATSUURA, et al.				
				FILING DATE		GROUP		
				July 11, 2003		1794		
				U.S. PATENT DOCUMENTS				
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS		ILING DATE PPROPRIATE
	AA	6,534,199 B1	03/18/2003	HOSOKAWA, et al. (corresponds to WO 01/21729)				
	AĐ	6,657,084 B2	12/02/2003	HOSOKAWA, et al.				
	AC	7,081,550 B2	07/25/2006	HOSOKAWA, et al.				
	AD							
			FO	REIGN PATENT DOCUMENTS				
		DOCUMENT NUMBER	DATE	COUNTRY		TRANSL YES		LATION NO
	AE	WO 01/21729	03/29/2001	WIPO (corresponds to US 6,534,199 B ⁻¹ EP 1 167 488 A1)	1 and			
	AF	EP 1 167 488 A1	01/02/2002	Europe (corresponds to WO 01/21729)				
	AG	WO 00/39247	07/06/2000	WIPO (English abstract only)				
	AH	JP 2001-131541	05/15/2001	Japan (English abstract only)				
	Al	JP 2001-052868	02/23/2001	Japan (English abstract only)				
	AJ	EP 1 061 112 A1	12/20/2000	Europe				
	AK	EP 1 666 561 A1	06/07/2006	Europe				
	AL	EP 1 775 335 A2	04/18/2007	Europe	-			
	AM	WO 02/20460 A1	03/14/2002	WIPO (English abstract only)				
	AN	JP 2002-080433	03/19/2002	Japan (English abstract only)				
	AO	JP 3998903	08/17/2007	Japan (with English translation) (corresp JP 2002-080433)	corresponds to			
	AP	EP 1 219 590 A1	07/03/2002	Europe				
	AQ	WO 02/102118 A1	12/19/2002	WIPO (English abstract only)				
	AR	EP 1 404 160 A1	03/31/2004	Europe				
	AS	WO 02/38524 A1	05/16/2002	WIPO (English abstract only)				
	ΑT	JP 2001-335516	12/04/2001	Japan (English abstract only)				
	AU	EP 1 333 018 A1	08/06/2003	Europe				
	AV	JP 2002-198183	07/12/2002	Japan (English abstract only)				
		OTHER R	EFERENCES (Including Author, Title, Date, Pertinent	t Pages, e	tc.)		
	AW	C.W. TANG, et al., A	opl. Phys. Lett.,	Vol. 51, No. 12, pp. 913-915 (1987)				
	AX							
	AY						·	
	AZ				Addi	itional Refe	erences	sheet(s) attached
Evaminar						ate Considered		
Examiner								
				t citation is in conformance with MPEP 60 in with next communication to applicant.	09; Draw li	ne through	citation	if not in

Form PTO 1449		U.S. DEPARTMEN	T OF COMMERCE	ATTY DOCKET NO.		SERIAL NO.			
(Modified) PATENT AND TRAD		DEMARK OFFICE	240064US0		10/617,397				
				APPLICANT					
LIST OF	REFE	RENCES CITED BY A	PPLICANT	Masahide MATSUURA, et al.		Т			
				FILING DATE		GROUP			
				July 11, 2003		1794			
				U.S. PATENT DOCUMENTS					
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB FILING DATE CLASS IF APPROPRIATE			
	BA								
	BB								
	ВС								
	BD				ļ <u>.</u>				
	BE								
	BF								
	BG								
	ВН								
	ВІ								
	BJ						1.1214777 777		
	вк								
	BL								
	ВМ								
	BN								
			FO	REIGN PATENT DOCUMENTS					
		DOCUMENT NUMBER	DATE	COUNTRY		TRANSLATION YES NO			
	во	EP 1 347 671 A1	09/24/2003	Europe					
	BP	WO 01/48116 A1	07/05/2001	WIPO (English abstract only)	_				
	BQ	JP 2001-250690	09/14/2001	Japan (English abstract only)					
	BR	JP 2007-201491	08/09/2007	Japan (English abstract only)					
	BS	EP 1 182 244 A1	02/27/2002	Europe					
	вт	WO 01/23497 A1	04/05/2001	WIPO (English abstract only)					
	BU	EP 1 757 670 A2	02/28/2007	Europe					
	BV								
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)									
	BW								
	вх								
	BY								
	BZ				Addi	tional Refe	rences sheet(s) attached		
Examiner					Date Cor	Date Considered			
*Examiner: In conformance	itial if re	eference is considered t considered. Include o	, whether or not copy of this form	t citation is in conformance with MPEP of with next communication to applicant.	609; Draw li	ne through	citation if not in		